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Master of Computer Applications

CAPOL403R01: Computer Organization & Architecture

Unit III: Lecture 1  
Memory System Overview

Dr. D. MURALIDHARAN  
School of Computing  
SASTRA Deemed to be University

# Characteristics of memory

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- Location
- Capacity
- Unit of transfer
- Access method
- Performance
- Physical type
- Physical characteristics
- Organization

# Location

- Internal

- Internal memory has a direct communication with the processor
- Usually, they are always attached to the processor
- Example: processor register, cache memory and internal (primary) memory

- External

- External memories are communicated with the processor through IO controller.
- These are slow, high capacity memories.
- Usually they are attached to the computer when needed and detached from it when not needed.
- Eg Optical disks, pen drives

# Capacity

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- Words
  - Internal memory capacity is expressed in terms of words (1, 2 or 4 bytes)
- Bytes
  - The capacity of peripheral devices is expressed in terms of bytes

# Unit of transfer

- Word
  - The communication between processor and internal memory is in terms of words (bytes/words)
- Block
  - The communication between processor and external memory is in terms of blocks (blocks of bytes)

# Accessing method

- Sequential access

- The read/write head is moved from current location to the desired location in order and reject the addresses (or records) in between.
- The accessing time will vary depends on the 'distance' between the current location of the header and the desired location
- Eg: Tape units

- Direct access

- Individual blocks or records have a unique address based on physical location
- Access is accomplished by direct access to reach a general vicinity plus sequential searching, counting, or waiting to reach the final location
- Access time is variable
- Eg: Disk units

# Accessing method...

- Random access

- Each addressable location in memory has a unique, physically wired-in addressing mechanism
- Same, constant amount of time is needed to access all locations
- Eg: Main memory

- Associative access

- This is a special kind of random access
- It enables one to make a comparison of desired bit locations within a word for a specified match
- This comparison will be done for all words simultaneously
- Thus, a word is retrieved based on a portion of its contents rather than its address
- Eg: Cache memory

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# Performance

- Access time (Latency)

- This is the time from the instant that an address is presented to the memory to the instant that data have been stored or made available for use
- For non-random-access memory, access time is the time it takes to position the read–write mechanism at the desired location

- Memory cycle time

- This time is the sum of access time and an additional time
- The additional time is needed to die-out the previous signals from bus
- Memory cycle time is concerned with the system bus, not the processor
- In random access memories, this is the minimum expected time between two successive memory accesses

# Performance...

- Transfer rate:

- This is the rate at which data can be transferred into or out of a memory unit
- It is equal to  $1/\text{cycle time}$  for random access memories
- For non-random-access memories, it is calculated using the formula:

$$T_n = T_A + (n/R)$$

where,

$T_n$  = Average time to read or write  $n$  bits

$T_A$  = Average access time

$n$  = Number of bits

$R$  = Transfer rate, in bits per second (bps)

# Physical type

- Semiconductor memories
- Magnetic surface (disks & tapes)
- Optical disks
- Magneto-optical disks



# Physical Characteristics

- Volatile
  - Information is lost after the power is off due to leakage
  - Usually refresh units are necessary to keep the information
- Non-volatile
  - No electrical power is needed to keep the information
- Erasable
  - The memory content can be erased using UV rays or by applying electrical pulses
  - The memory can be re-written
- Non-erasable
  - They are only one time written and then used to read

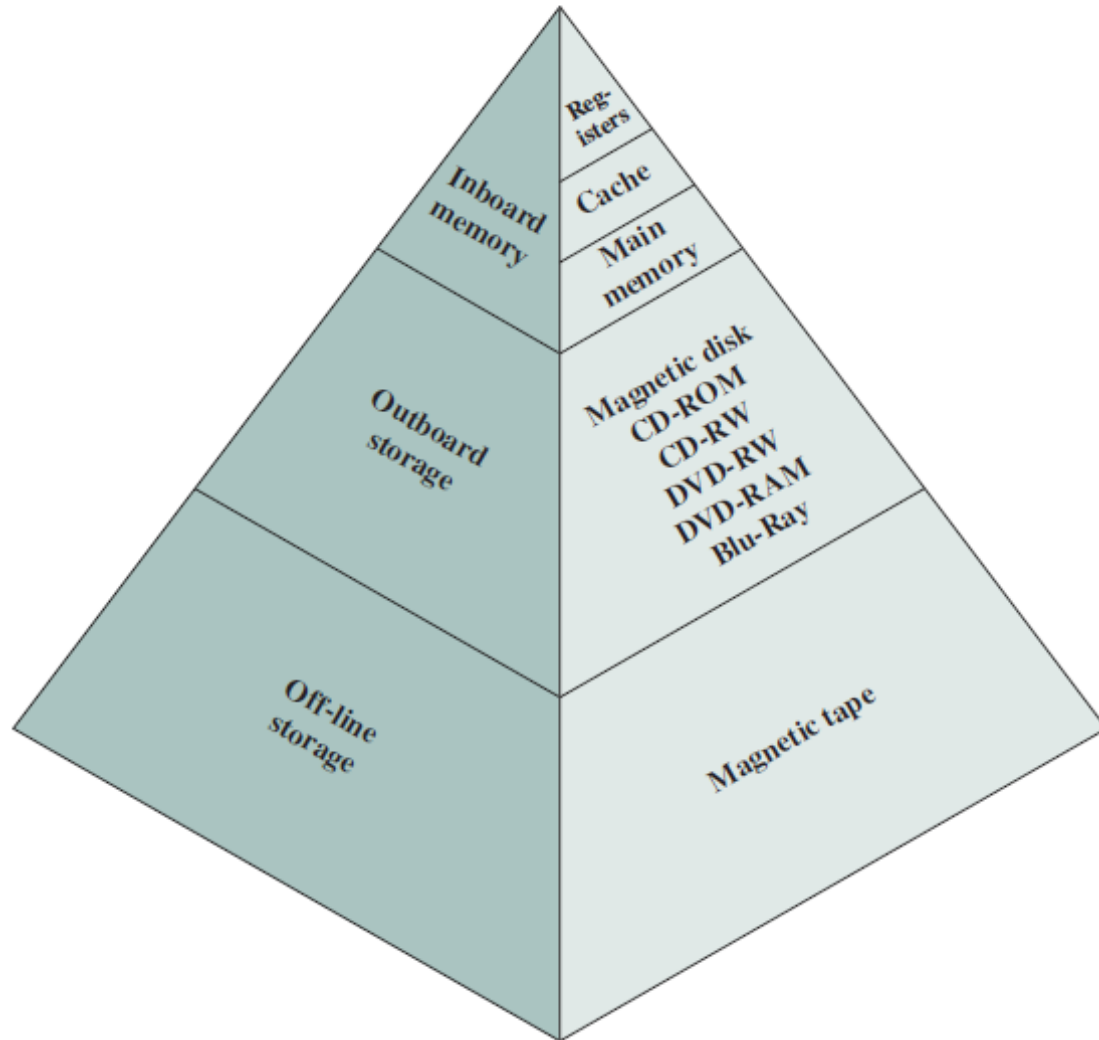
# Characteristics of Memory systems

<b>Location</b>	<b>Performance</b>
Internal (e.g., processor registers, cache, main memory)	Access time
External (e.g., optical disks, magnetic disks, tapes)	Cycle time
<b>Capacity</b>	Transfer rate
Number of words	<b>Physical Type</b>
Number of bytes	Semiconductor
<b>Unit of Transfer</b>	Magnetic
Word	Optical
Block	Magneto-optical
<b>Access Method</b>	<b>Physical Characteristics</b>
Sequential	Volatile/nonvolatile
Direct	Erasable/nonerasable
Random	<b>Organization</b>
Associative	Memory modules

# Memory Hierarchy

- Design constraints
  - Capacity
  - Performance
  - Cost
- Relationship
  - Faster access time – expensive storage (cost per bit is high)
  - Greater capacity – cheaper storage (cost per bit is low)
  - Greater capacity – low performance (slow access time)

# Memory Hierarchy



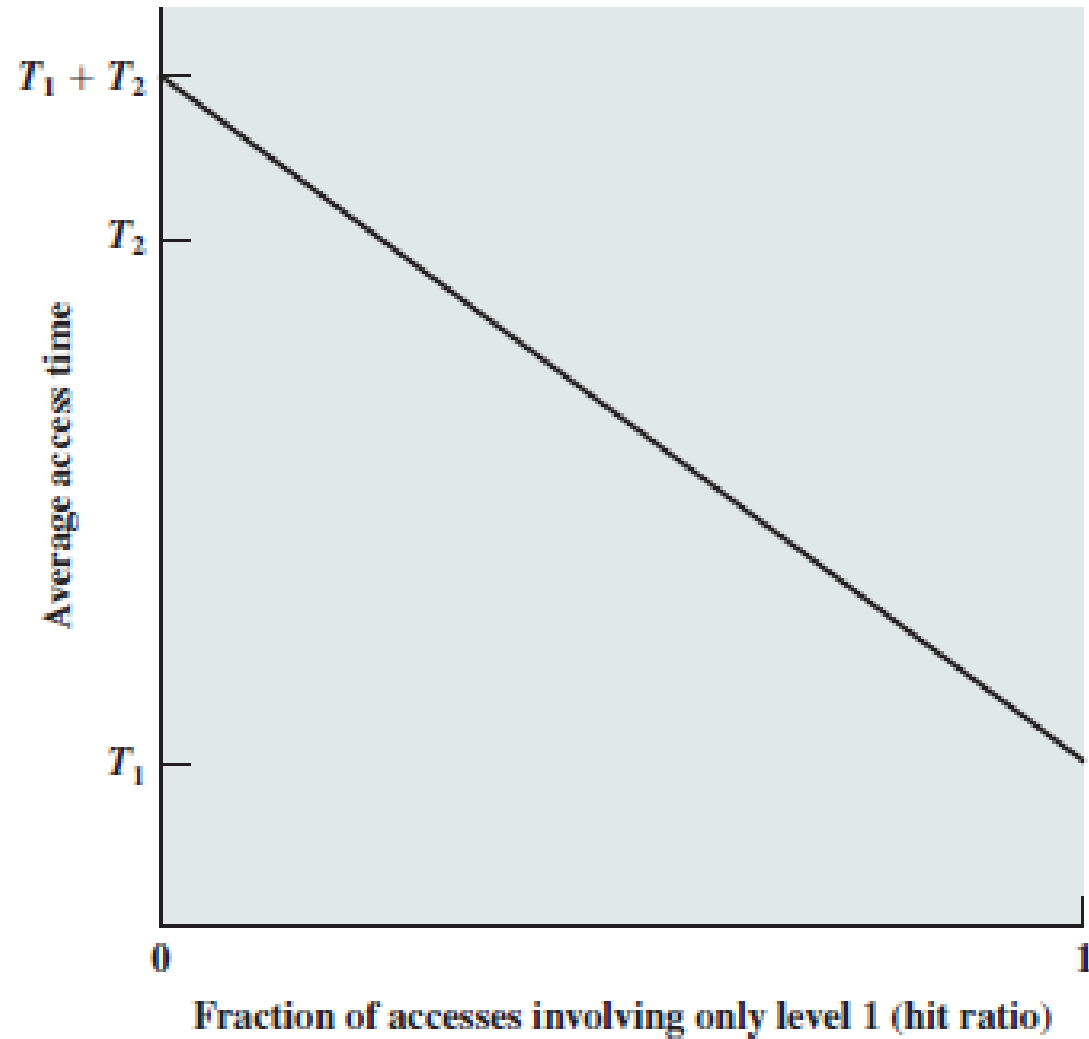
- Hierarchy (top to bottom)
  - Decreasing cost per bit
  - Increasing capacity
  - Increasing access time
  - Decreasing frequency of access of the memory by the processor
    - locality of reference

# A “toy” example

- The processor has access to two levels of memory
- L1 has 1000 words with access time of 0.01 microsecond
- L2 contains 100,000 words with access time of 0.1 microsecond
- If the word is in L1, it is accessed directly by the processor
- If the word is in L2, it is transferred to L1 and is accessed from L1
- Ignore the time to determine whether a word is in L1 or in L2
- Hit (H): Fraction of all memory accesses that are found in L1
- When  $H=95\%$ , then average time to access memory is  
 $(0.95 \times 0.01) + (0.05 \times 0.11) = 0.0095 + 0.0055 = 0.015$  microsecond
- The average time is closer to L1 access time than L2 access time



# Performance of access



- $T_1$  is the access time of faster memory
- $T_2$  is the access time of slower memory

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*Thank you*